

SN54HC20, SN74HC20 DUAL 4-INPUT POSITIVE-NAND GATES

D2684, DECEMBER 1982 — REVISED SEPTEMBER 1987

- Package Options Include Plastic "Small Outline" Packages, Ceramic Chip Carriers, and Standard Plastic and Ceramic 300-mil DIPs
- Dependable Texas Instruments Quality and Reliability

description

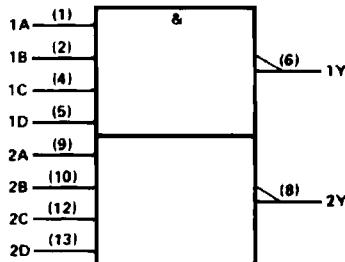
These devices contain two independent 4-input NAND gates. They perform the Boolean functions $Y = A \cdot B \cdot C \cdot D$ or $Y = \bar{A} + \bar{B} + \bar{C} + \bar{D}$ in positive logic.

The SN54HC20 is characterized for operation over the full military temperature range of -55°C to 125°C . The SN74HC20 is characterized for operation from -40°C to 85°C .

FUNCTION TABLE (each gate)

INPUTS				OUTPUT
A	B	C	D	Y
H	H	H	H	L
L	X	X	X	H
X	L	X	X	H
X	X	L	X	H
X	X	X	L	H

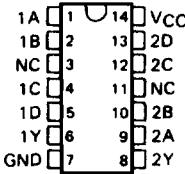
logic symbol†



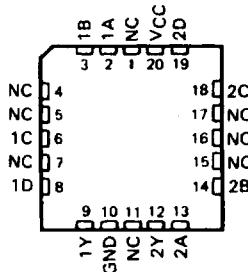
†This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for D, J, and N packages.

SN54HC20 . . . J PACKAGE
SN74HC20 . . . D OR N PACKAGE
(TOP VIEW)

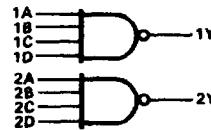


SN54HC20 . . . FK PACKAGE
(TOP VIEW)



NC — No internal connection

logic diagram (positive logic)



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SN54HC20, SN74HC20 DUAL 4-INPUT POSITIVE-NAND GATES

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absolute maximum ratings over operating free-air temperature range[†]

Supply voltage, V _{CC}	-0.5 V to 7 V
Input clamp current, I _{IK} (V _I < 0 or V _I > V _{CC})	±20 mA
Output clamp current, I _{OK} (V _O < 0 or V _O > V _{CC})	±20 mA
Continuous output current, I _O (V _O = 0 to V _{CC})	±25 mA
Continuous current through V _{CC} or GND pins	±50 mA
Lead temperature 1.6 mm (1/16 in) from case for 60 s: FK or J package	300°C
Lead temperature 1.6 mm (1/16 in) from case for 10 s: D or N package	260°C
Storage temperature range	-65°C to 150°C

[†]Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

V _{CC}	Supply voltage	SN54HC20			SN74HC20			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V _{CC}	V _{CC} = 2 V	2	5	6	2	5	6	V
V _{IH}	High-level input voltage	V _{CC} = 4.5 V	1.5		V _{CC} = 4.5 V	1.5		V
		V _{CC} = 6 V	3.15		V _{CC} = 6 V	3.15		
			4.2			4.2		
V _{IL}	Low-level input voltage	V _{CC} = 2 V	0	0.3	V _{CC} = 2 V	0	0.3	V
		V _{CC} = 4.5 V	0	0.9	V _{CC} = 4.5 V	0	0.9	
		V _{CC} = 6 V	0	1.2	V _{CC} = 6 V	0	1.2	
V _I	Input voltage		0	V _{CC}		0	V _{CC}	V
V _O	Output voltage		0	V _{CC}		0	V _{CC}	V
t _t	Input transition (rise and fall) times	V _{CC} = 2 V	0	1000	V _{CC} = 4.5 V	0	1000	ns
		V _{CC} = 4.5 V	0	500	V _{CC} = 6 V	0	500	
		V _{CC} = 6 V	0	400		0	400	
T _A	Operating free-air temperature		-55	125	T _A = -40	-40	85	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V _{CC}	TA = 25°C			SN54HC20		SN74HC20		UNIT
			MIN	TYP	MAX	MIN	MAX	MIN	MAX	
V _{OH}	V _I = V _{IH} or V _{IL} , I _{OH} = -20 μA	2 V	1.9	1.998		1.9		1.9		V
		4.5 V	4.4	4.499		4.4		4.4		
		6 V	5.9	5.999		5.9		5.9		
	V _I = V _{IH} or V _{IL} , I _{OH} = -4 mA	4.5 V	3.98	4.30		3.7		3.84		
V _{OL}	V _I = V _{IH} or V _{IL} , I _{OL} = 20 μA	6 V	5.48	5.80		5.2		5.34		V
		2 V	0.002	0.1		0.1		0.1		
		4.5 V	0.001	0.1		0.1		0.1		
	V _I = V _{IH} or V _{IL} , I _{OL} = 4 mA	6 V	0.001	0.1		0.1		0.1		
I _I	V _I = V _{CC} or 0	4.5 V	0.17	0.26		0.4		0.33		V
		6 V	0.15	0.26		0.4		0.33		
	V _I = V _{CC} or 0, I _O = 0	6 V	±0.1	±100		±1000		±1000		nA
I _{CC}	V _I = V _{CC} or 0, I _O = 0	6 V		2		40		20		μA
C _I		2 to 6 V		3	10		10		10	pF

**SN54HC20, SN74HC20
TRIPLE 3-INPUT POSITIVE-NAND GATES**

switching characteristics over recommended operating free-air temperature range (unless otherwise noted), $C_L = 50 \text{ pF}$ (see Note 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CC}	T _A = 25°C			SN54HC20		SN74HC20		UNIT
				MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t_{pd}	A, B, C, or D	Y	2 V	45	110		165		140		ns
			4.5 V	14	22		33		28		
			6 V	11	19		28		24		
t_t		Y	2 V	27	75		110		95		ns
			4.5 V	9	15		22		19		
			6 V	7	13		19		16		

C _{pd}	Power dissipation capacitance per gate	No load, T _A = 25°C	25 pF typ
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NOTE 1: Load circuit and voltage waveforms are shown in Section 1.

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